Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/740,268	LAM ET AL.	
Examiner	Art Unit	
Douglas N. Washburn	2863	

	SEARCHED		
Class	Subclass	Date	Examiner
702	108	5/5/2005	428
	117-123	A	Λ
	182, 183		
	186, 189		
	FOR 134		
	FOR 160		
709	223, 224		
714	40, 43		
717	124-131		V
	168	5/5/2005	m

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST text search	5/5/2005	bm
IEEE text search	5/5/2005	b 3
STIC PLUS search	5/5/2005	w
Discussed with Nghiem, M; suggested 702/119-123, 182, 183, 186, 189	5/5/2005	m
Discussed with Steelman, M; suggested 717/124-131, 168	5/5/2005	m